EIC Tracking Simulations: µRWell Material Budget Benchmarks

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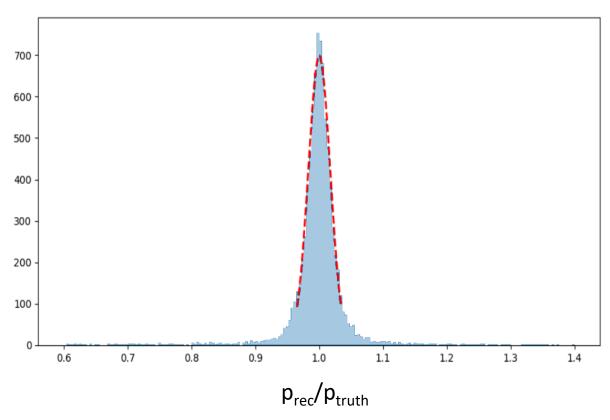
Setup

- Using Fun4All software stack to run simulations
- Began with "default" ECCE geometry (https://github.com/ECCE-EIC/macros)
 - · Disabled all components except tracking detectors and materials within tracking volume
 - Everything else left the same
 - Note: default setup still fails to meet PWG tracking requirements in most areas
- Reproduced results from S. Maple et al. silicon tracking study (PDF)
- Next, replaced barrel µRWell geometry with a simplified version (single cylinder) for each detector
 - Parameterized thickness of this cylinder to easily change X₀ of detector
 - Swept across X₀ and compared to default configuration

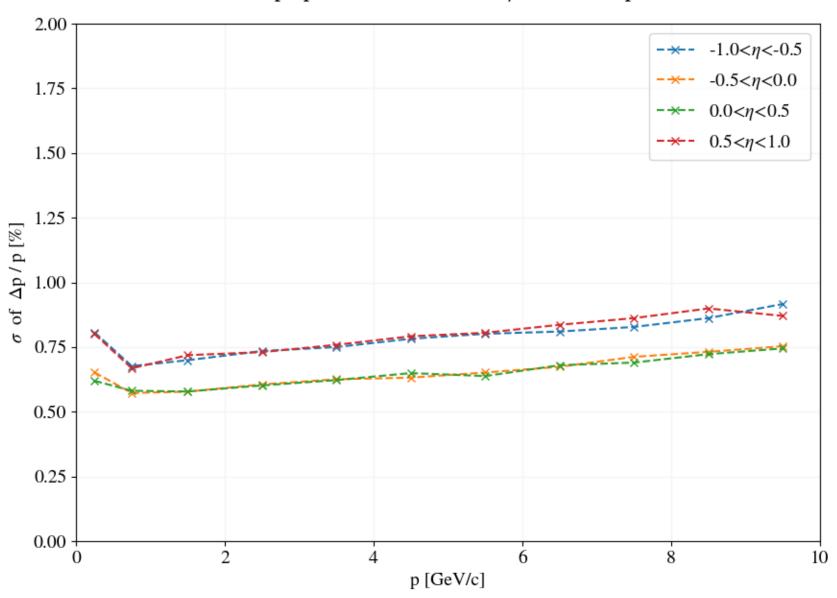
Details

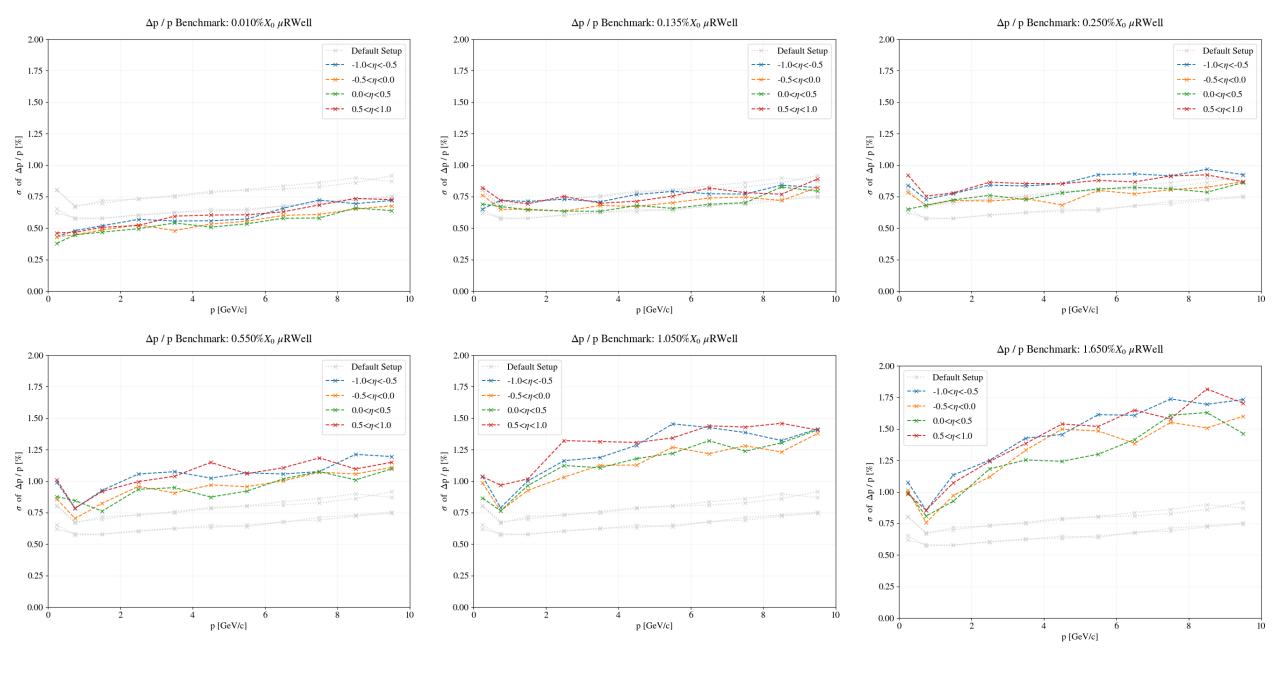
- Generated π^- particles uniformly in $\eta,~p_t$ with ranges -1.5< η <1.5 and 0 GeV/c< p_t <10.0 GeV/c
 - 500,000 particles to get stats for default configuration, 50,000 for each X_0
- Rescaled sPHENIX field map from 1.5T to 1.4T
- Create histogram of p_{rec}/p_{truth} , fit gaussian to distribution and record σ
 - Perform this process over bins in η and p
- (exact process S. Maple et al. used)
- Si sagitta layer material changed from 0.05% X_0 to 0.55% X_0

Relative Momentum Distribution Fit (example)

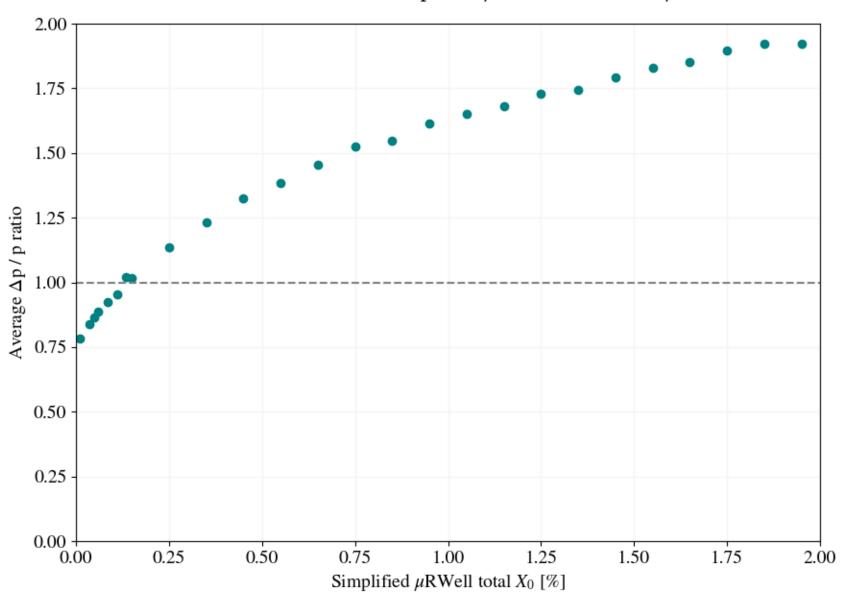


 Δp / p Benchmark: Default $\mu RWell$ Setup

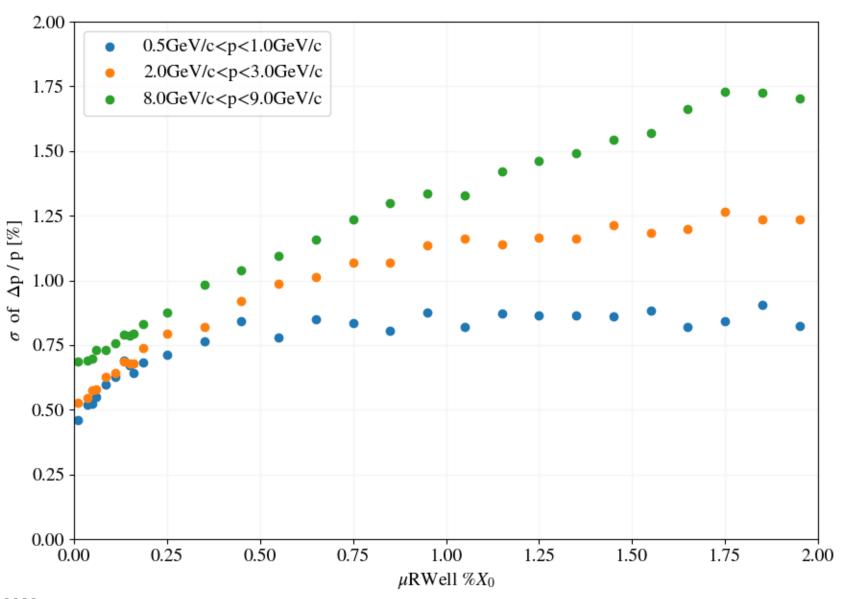




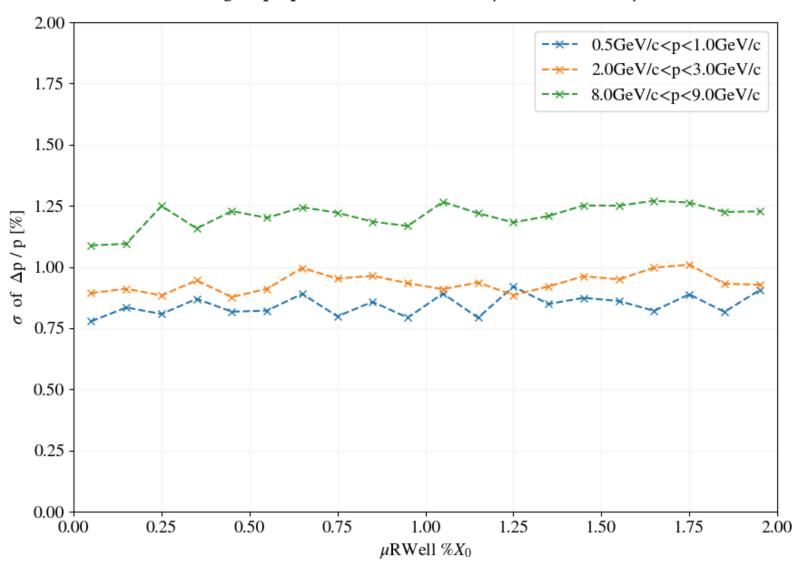
Resolution ratio between simplified μ RWell and default μ RWell



Average $\Delta p / p$ Benchmark for $-1.0 < \eta < 1.0$



Average Δp / p Benchmark for -1.5< η <-1.0 and 1.0< η <1.5



 $\eta\text{=+/-1.0}$ is near the edge of the barrel, so very little changes with X_0 after that

Δp / p Benchmark: $0.010\% X_0 \mu RWell$

